



Title of Change:	Data Sheet Correction for NCP51200 / NCP51400 Family of Devices		
Effective date:	3 May 2016		
Contact information:	Contact your local ON Semiconductor Sales Office or <alan.garlington@onsemi.com>		
Type of notification:	ON Semiconductor will consider this change accepted.		
Change category:	<input type="checkbox"/> Wafer Fab Change <input type="checkbox"/> Assembly Change <input type="checkbox"/> Test Change <input checked="" type="checkbox"/> Other_ Datasheet		
Change Sub-Category(s):	<input type="checkbox"/> Manufacturing Site Change/Addition <input type="checkbox"/> Material Change <input checked="" type="checkbox"/> Datasheet/ Product Doc Change <input type="checkbox"/> Manufacturing Process Change <input type="checkbox"/> Product specific change <input type="checkbox"/> Shipping/Packaging/Marking <input type="checkbox"/> Other: _____		
Sites Affected:	<input type="checkbox"/> All site(s) <input checked="" type="checkbox"/> not applicable <input type="checkbox"/> ON Semiconductor site(s) : <input type="checkbox"/> External Foundry/Subcon site(s)		
Description and Purpose:	There is no change to the parts or the testing of these parts as a result of this notification. This is a data sheet correction only. The Vcc UVLO Threshold minimum limit in the data sheet Electrical Characteristics table will be changed to match the value which is actually being tested. Vcc UVLO Threshold Wake Up, TA = +25C Previous Min Value = 2.2 V New Min Value = 2.15 V		
List of affected Standard Parts:	NCP51200MNTWG NCP51403MNTXG NCP51200MNTXG NCV51200MNTXG NCP51400MNTXG NCV51200MWTXG NCP51401MNTXG NCV51400MNTXG NCP51402MNTXG NCV51400MWTXG		